Sheet 1 of 1									
FORM PTE 1449 (modified)  U.S. DEPARTMENT OF COMMERCE				ATTY DOCKET NO. 2001_1217A		,_no. 941,693			
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*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DAT APPROPRIA		
Kcj	АА	5,443,738	8/22/95	Bhatnagar et al.	210	641			
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		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLAT YES	TION NO	
Kef	AI	0 567 915	11/3/93	EP			Abstract		
Kej	AJ	0 878 494	11/18/98	EP		-	-		
KCJ	AK	0 901 988	3/17/99	EP			Abstract		
	AL	2 255 914	5/30/74	<del>DT</del> DE	-				
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<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.